

Search Notes

Application/Control No.

10/699,918

Examiner

Dru M. Parries

Applicant(s)/Patent under
Reexamination

CERN, YEHUDA

Art Unit

2836

SEARCHED

| Class | Subclass | Date | Examiner |
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| 307 | 89 | 2/14/2006 | DMP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST search notes attached | 2/17/2006 | DMP |
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